## Applicant(s)/Patent Under Reexamination 10/827,358 HAN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Marissa L. Ferguson-Samreth 2854

Application/Control No.

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
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	ı	US-			
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	К	US-			
	L	US-			
	М	US-			

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## **NON-PATENT DOCUMENTS**

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